

BAR CODE LABEL



## U.S. PATENT APPLICATION

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RULE 60

CLASS

324

GROUP ART UNIT

2213

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\*\*CONTINUING DATA\*\*\*\*\*

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\*\*FOREIGN/PCT APPLICATIONS\*\*\*\*\*

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STATE OR  
COUNTRY

NY

SHEETS  
DRAWING

7

TOTAL  
CLAIMS

43

INDEPENDENT  
CLAIMS

5

FILING FEE  
RECEIVED

\$1,436.00

ATTORNEY DOCKET NO.

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TITLE

HIGH DENSITY INTEGRAL TEST PROBE AND FABRICATION METHOD

This is to certify that annexed hereto is a true copy from the records of the United States  
Patent and Trademark Office of the application which is identified above.

By authority of the  
COMMISSIONER OF PATENTS AND TRADEMARKS

Date

Certifying Officer